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Application/Control No.	Applicant(s)/Pater Reexamination	Applicant(s)/Patent under Reexamination	
10/814,858	TULI ET AL.		
Examiner	Art Unit		
Maria B. Marvich, PhD	1633		

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INTERFERENCE SEARCHED			
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Text word search SEQ ID NO:1		3/1/2007	MM ,

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST, PALM inventor search	7/8/2005	ММ		
EAST databases-USPAT, PGPUB, EPO, JPO, Derwent, IBM-IDB search notes attached	7/8/2005	MM		
STN databases-caplus, scisearch, Medline search notes attached	7/8/2005	ММ		
Stic-sequence search SEQ ID NO:1 and SEQ ID NO:2	7/8/2005	MM		
East, STN search updated search history attached	3/29/2006	ММ		
East, STN search updated search history attached	11/21/2006	ММ		
SEQ ID NO:2 including interference	11/16/06	MM		
East, STN search updated search history attached	3/1/2007	ММ		